Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/664,662	ISHIKAWA ET AL.
Examiner	Art Unit
Huy D. Nguyen	2617

SEARCHED						
Cla	iss	Subclass	Date		Examiner	
45	55	423	2/8/2006		HN	
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Upda	ated	search	10/6/	2006	F	IN
Upda	ated	search	3/17/	2007	۲	IN

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (USPAT, US-PGPUB, JPO, EPO, DERWENT). See search history printout.	2/8/2006	HN		
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	10/6/2006	HN		
East; Text search (USPAT, US- PGPUB, JPO, EPO, DERWENT). See search history printout.	3/17/2007	HN		
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